


<b>Search Notes</b>  	<b>Application/Control No.</b>  10586410	<b>Applicant(s)/Patent Under Reexamination</b>  SENF ET AL.
	<b>Examiner</b>  RAYMOND CHUNG	<b>Art Unit</b>  4145

SEARCHED			
Class	Subclass	Date	Examiner
8	115.51, 115.6	2/11/08; 2/13/08; 3/13/08	rc

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS search (see results)	2/11/08	rc
STIC search	3/13/08	rc
EAST search (see results)	2/11/08;	rc
	2/13/08; 3/13/08	
Inventor name search, PALM	3/13/08	rc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner